


<b>Search Notes</b>  	<b>Application/Control No.</b>  10822884	<b>Applicant(s)/Patent Under Reexamination</b>  YIP ET AL.
	<b>Examiner</b>  TANH Q NGUYEN	<b>Art Unit</b>  2182

SEARCHED			
Class	Subclass	Date	Examiner
360	all - limited search	01/05/07	TQN
361	all - limited search	01/05/07	TQN
711	all - limited search	01/05/07	TQN

SEARCH NOTES		
Search Notes	Date	Examiner
Consult SN 10/609,662 (US 6,915,977); inventor search - eDAN/East; IDS consideration	01/04/07	TQN
East Search - Results attached	01/05/07	TQN
rejection maintained	06/23/07	TQN
Consult SPE Kim Huynh and SPE Sam Hyung - 112 on range withdrawn, 103 maintained	09/12/07	TQN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner